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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/540,980	08/09/2006	Shinichi Terada	2691-000022/US	9530	
30593 HARNESS, D	7590 11/04/200 ICKEY & PIERCE, P.I	EXAMINER			
P.O. BOX 8910			KAO, CHIH CHENG G		
RESTON, VA	. 20195		ART UNIT	PAPER NUMBER	
			2882		
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			11/04/2008	PAPER	

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

## Advisory Action Before the Filing of an Appeal Brief

Application No.	Applicant(s)		
10/540,980	TERADA, SHINICHI		
Examiner	Art Unit		
Chih-Cheng Glen Kao	2882		

	Chih-Cheng Glen Kao	2882	
The MAILING DATE of this communication appe	ars on the cover sheet with the o	orrespondence add	ress
THE REPLY FILED 15 October 2008 FAILS TO PLACE THIS A	PPLICATION IN CONDITION FOR	R ALLOWANCE.	
<ol> <li>X The reply was filed after a final rejection, but prior to or on application, applicant must timely file one of the following application in condition for allowance; (2) a Notice of Appe for Continued Examination (RCE) in compliance with 37 C periods:</li> </ol>	the same day as filing a Notice of a eplies: (1) an amendment, affidavi al (with appeal fee) in compliance	Appeal. To avoid abar t, or other evidence, v with 37 CFR 41.31; o	hich places the (3) a Request
<ul> <li>a)  The period for reply expires 3 months from the mailing date</li> </ul>	of the final rejection		
b) The period for reply expires on: (1) the mailing date of this Ar no event, however, will the statutory period for reply expire la	dvisory Action, or (2) the date set forth		
Examiner Note: If box 1 is checked, check either box (a) or (I MONTHS OF THE FINAL REJECTION. See MPEP 706.07(f		FIRST REPLY WAS FI	LED WITHIN TWO
Extensions of time may be obtained under 37 CFR 1,136(a). The date where filed is the date for purposes of determining the period of exhausted winder 37 CFR 1,17(a) is calculated from: (1) the expiration date of the set forth in (b) above, if checked. Any reply received by the Office later may reduce any earned patient term adjustment. See 37 CFR 1,704(b). NOTICE OF APPEAL.	ension and the corresponding amount of hortened statutory period for reply origi	of the fee. The appropri- nally set in the final Office	ate extension fee e action; or (2) as
<ol> <li>The Notice of Appeal was filed on A brief in compl filing the Notice of Appeal (37 CFR 41.37(a)), or any exter Notice of Appeal has been filed, any reply must be filed wi</li> </ol>	sion thereof (37 CFR 41.37(e)), to	avoid dismissal of the	
<u>AMENDMENTS</u>			
The proposed amendment(s) filed after a final rejection, be     (a) They raise new issues that would require further containing the state of th	sideration and/or search (see NOT		cause
(b) ☐ They raise the issue of new matter (see NOTE below     (c) ☐ They are not deemed to place the application in bett     appeal: and/or		lucing or simplifying t	ne issues for
(d) ☐ They present additional claims without canceling a c NOTE: (See 37 CFR 1.116 and 41.33(a)).	orresponding number of finally reje	ected claims.	
<ol> <li>The amendments are not in compliance with 37 CFR 1.12</li> <li>Applicant's reply has overcome the following rejection(s):</li> </ol>		mpliant Amendment (	PTOL-324).
Newly proposed or amended claim(s) would be all non-allowable claim(s).		imely filed amendmer	nt canceling the
<ol> <li>So purposes of appeal, the proposed amendment(s): a) [how the new or amended claims would be rejected is prov. The status of the claim(s) is (or will be) as follows: Claim(s) allowed:</li> </ol>		be entered and an e	xplanation of
Claim(s) objected to: <u>12 and 16</u> . Claim(s) rejected: <u>9-11 and 13-15</u> . Claim(s) withdrawn from consideration: AFFIDAVIT OR OTHER EVIDENCE			
8. The affidavit or other evidence filed after a final action, but	hefore or on the date of filing a No	tion of Annual will no	he entered
because applicant failed to provide a showing of good and was not earlier presented. See 37 CFR 1.116(e).			
<ol> <li>The affidavit or other evidence filed after the date of filing entered because the affidavit or other evidence failed to or showing a good and sufficient reasons why it is necessary</li> </ol>	vercome <u>all</u> rejections under appea and was not earlier presented. Se	and/or appellant fail ee 37 CFR 41.33(d)(1	s to provide a ).
<ol> <li>The affidavit or other evidence is entered. An explanation REQUEST FOR RECONSIDERATION/OTHER</li> </ol>	of the status of the claims after er	ntry is below or attach	ed.
<ol> <li>The request for reconsideration has been considered but See Continuation Sheet.</li> </ol>	does NOT place the application in	condition for allowan	ce because:
12.  Note the attached Information Disclosure Statement(s). (13.  Other:	PTO/SB/08) Paper No(s)		

/Chih-Cheng Glen Kao/ Primary Examiner, Art Unit 2882 Continuation of 11, does NOT place the application in condition for allowance because:

Regarding at least claims 9 and 15, Applicant argues that Koppel et al. fails to disclose irradiating the insulator film with X-rays from the insulator film's surface side at an incident angle which is set to be larger than a total-reflection critical angle insulator. The surface is a surface side at an incident angle which is set to be larger than a total-reflection critical angle of the substrate. The Examiner disagrees. As seen in Figure 3, Koppel et al. shows two critical angles 306 and 308, which correspond to the critical angle of the insulator (fig. 3, #308), and the critical angle of the substrate (fig. 3, #308), As seen in Figure 3, the reflection angle increases as the incident angle is changed (fig. 4, #406; and col. 4, fines 7-25) as further explained by Koppel et al. Since the angle of incidence goes through a range of angles, as evidenced by the graph in Figure 3, Koppel et al. will necessarily irradiate the insulator film with X-rays from the insulator film's surface side at an incident angle with is set to be larger than a total-reflection critical angle of the insulator, but less than 1.3 times a total-reflection critical angle of the substrate, at some point in that graph of Figure 3. Therefore, Koppel et al.

Furthermore, with regards to claim 15, Applicant submits that there is an inconsistent statement in suggesting that Koppel both does and does not disclose a point focus X-ray source. The Examiner disagrees with this contention. As seen on page 3 of the Office Action mailed July 7, 2008, the Examiner stated that Koppel et al. (i.e., US 6507634) does not disclose a point focus X-ray source. The Examiner also stated that Koppel (i.e., US 6519549) does disclose a point focus X-ray source. However, the Examiner never stated that Koppel (i.e., US 5619549) does not disclose a point focus X-ray source. Therefore, the Examiner only stated that Koppel (i.e., US 5619548) discloses a point focus X-ray source.

Applicant also argues that Koppel only teaches an X-ray source, not a point focus X-ray source. The Examiner disagrees. As seen in Figure 4 of Koppel, the X-ray source in the X-ray source (fig. 4, #31) start from a point focus at the X-ray source. Therefore, Koppel does disclose a point focus X-ray source.

In conclusion, Applicant's arguments are not persuasive, and the respective claims remain rejected.